

MC3216-VB Datasheet

N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (TYP.)			
30	0.016 at V _{GS} = 10 V	9	9 nC			
30	0.019 at V _{GS} = 4.5 V	8	9 110			

FEATURES

• Trench power MOSFET

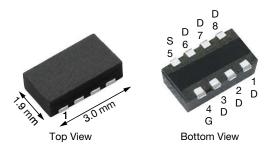


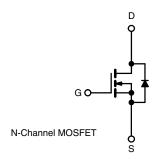
APPLICATIONS

- Load switches
 - Notebook PC









PARAMETER Drain-Source Voltage		SYMBOL	LIMIT	UNIT	
		V _{DS}	30	V	
Gate-Source Voltage		V _{GS} ± 20		v	
	T _C = 25 °C		9		
Continuous Drain Current /T 150 °C)	T _C = 70 °C	,	6 ^a		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	l _D	6 a, b, c		
	T _A = 70 °C		6 a, b, c	A	
Pulsed Drain Current		I _{DM}	30		
0 " 0 5 5 1 0 1	T _C = 25 °C	,	5.2		
Continuous Source-Drain Diode Current	T _A = 25 °C	ls -	2.1 ^{b, c}		
	T _C = 25 °C		6.3		
Martin or Barra Biratastica	T _C = 70 °C		4		
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{b, c}	W	
	T _A = 70 °C		1.6 ^{b, c}		
Operating Junction and Storage Temperatur	T _J , T _{stg}	-55 to +150			
Soldering Recommendations (Peak Tempera	'	260	°C		

THERMAL RESISTANCE RATINGS								
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT				
Maximum Junction-to-Ambient a, c, d	t ≤ 5 s	R_{thJA}	40	50	°C/W			
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	15	20	C/VV			

Notes

- a. Package limited, $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under steady state conditions is 95 °C/W.
- e. The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- f. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

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PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	$\Delta V_{DS}/T_J$		31	-	mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-5.1	-	mv/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1.2	-	2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
Zava Cata Valtaga Dvaig Courset	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V	=.	-	1	μΑ
Zero Gate Voltage Drain Current		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C	-	-	5	
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	20	-	-	Α
Dunin Course On Otata Basistana 2	Б	V _{GS} = 10 V, I _D = 9.1 A	-	0.016	-	Ω
Drain-Source On-State Resistance a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 8.1 A	-	0.019	-	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 9.1 A	-	30	-	S
Dynamic ^b						
Input Capacitance	C _{iss}		=	1200	-	pF
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	180	-	
Reverse Transfer Capacitance	C _{rss}		=.	80	-	
Total Cata Chaves	Q _g	$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 9.1 \text{ A}$	=.	19	29	nC
Total Gate Charge			-	9	14	
Gate-Source Charge	Q_{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 9.1 \text{ A}$	-	3.5	-	
Gate-Drain Charge	Q_{gd}		-	2.3	-	
Gate Resistance	R_g	f = 1 MHz	-	3	-	Ω
Turn-On Delay Time	t _{d(on)}		-	20	30	
Rise Time	t _r	. , , ,	-	12	20]
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 7.3$ A, $V_{GEN} = 4.5$ V, $R_g = 1~\Omega$	-	20	30	
Fall Time	t _f		-	10	15	
Turn-On Delay Time	t _{d(on)}		-	10	15	ns -
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_L = 2.1 \Omega$	-	10	15	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 7.3$ A, V_{GEN} = 10 V, R_g = 1 Ω	-	20	30	
Fall Time	t _f		-	10	15	
Drain-Source Body Diode Characteristi	cs					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	-	-	5.2	
Pulse Diode Forward Current	I _{SM}		-	-	30	Α
Body Diode Voltage	V_{SD}	$I_S = 7.3 \text{ A}, V_{GS} = 0 \text{ V}$	-	0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}		-	20	40	ns
Body Diode Reverse Recovery Charge Q _{rr}		1 70 A 41/44 400 A / - T 05 00	-	10	20	nC
Reverse Recovery Fall Time	t _a	$I_F = 7.3 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	11	-	ns
Reverse Recovery Rise Time	t _b		_	9	_	

Notes

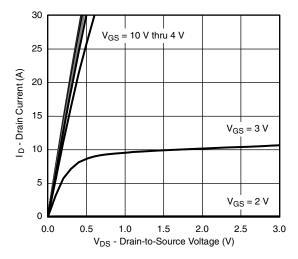
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

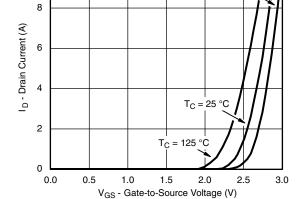
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



 $T_{C} = -55$

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

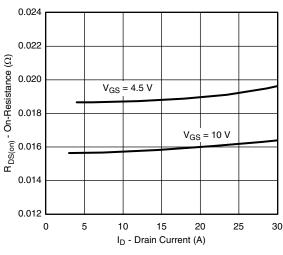


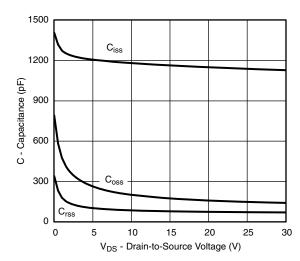


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Output Characteristics

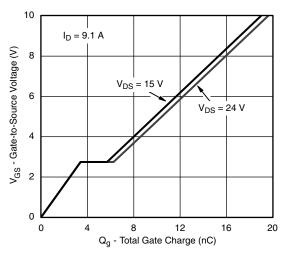
Transfer Characteristics

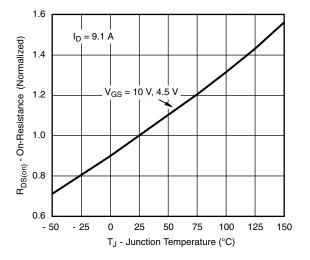




On-Resistance vs. Drain Current

Capacitance





Gate Charge

On-Resistance vs. Junction Temperature

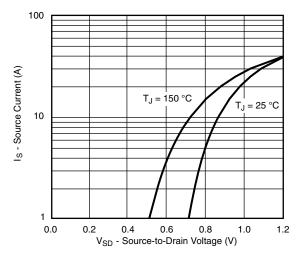


 $T_J = 125~^{\circ}C$

 $T_J = 25 \, ^{\circ}C$

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



0 2 4 6 8 V_{GS} - Gate-to-Source Voltage (V)

0.05

0.04

0.03

0.02

0.01

0

0 ∐ 10⁻³

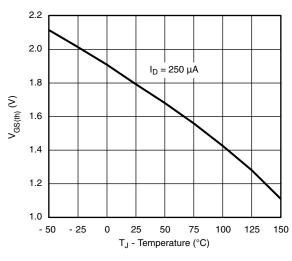
10-2

10⁻¹

 $R_{DS(on)}$ - On-Resistance (Ω)

 $I_D = 9.1 \text{ A}$

Source-Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

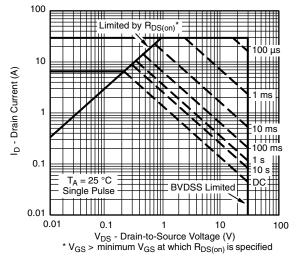


Time (s)

10

100

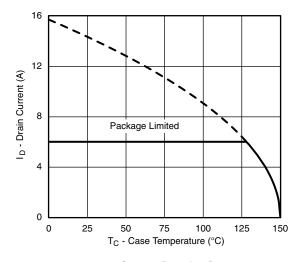
600

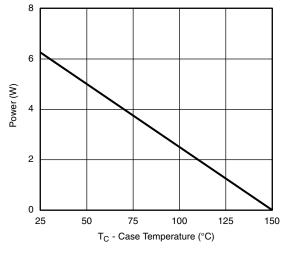


Safe Operating Area, Junction-to-Ambient



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Current Derating ^a

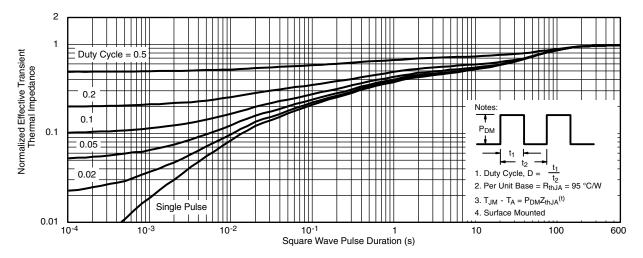
Power Derating

Note

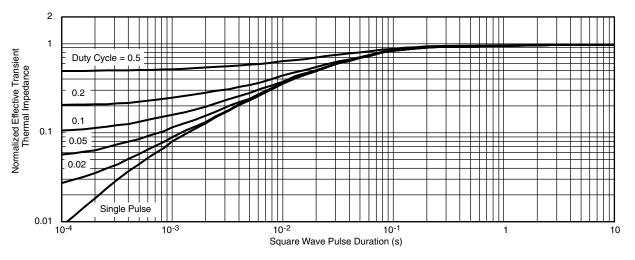
a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



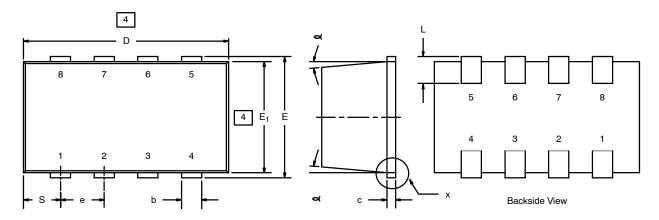
Normalized Thermal Transient Impedance, Junction-to-Ambient

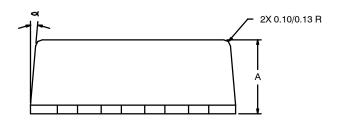


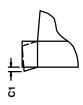
Normalized Thermal Transient Impedance, Junction-to-Foot



DFN 3x2







DETAIL X

NOTES:

- 1. All dimensions are in millimeaters.
- 2. Mold gate burrs shall not exceed 0.13 mm per side.
- 3. Leadframe to molded body offset is horizontal and vertical shall not exceed
- 4. Dimensions exclusive of mold gate burrs.
- 5. No mold flash allowed on the top and bottom lead surface.

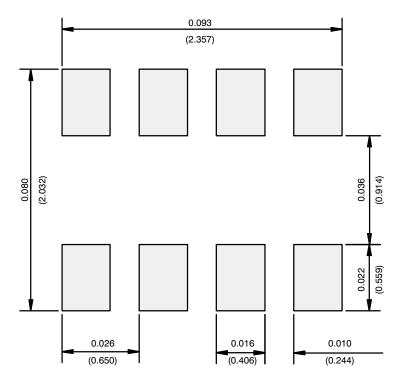
	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	1.00	-	1.10	0.039		0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.1	0.15	0.20	0.004	0.006	0.008	
c1	0	-	0.038	0		0.0015	
D	2.95	3.05	3.10	0.116	0.120	0.122	
E	1.825	1.90	1.975	0.072	0.075	0.078	
E ₁	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.65 BSC			0.0256 BSC			
L	0.28	-	0.42	0.011	-	0.017	
S	0.55 BSC			0.022 BSC			
9	5°Nom			5°Nom			
ECN: C-03528—Rev. F, 19-Jan-04 DWG: 5547							

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RECOMMENDED MINIMUM PADS FOR DFN3x2



Recommended Minimum Pads Dimensions in Inches/(mm)



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